

A DISCUSSION of SOURCES of ERROR in LASER–SPECKLE BASED SYSTEMS

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Abstract

Applying laser–speckle techniques in the material sciences as well as in methods to characterize surface conditions of specimen has become the method of choice especially if a non–contacting principle is sought. This is almost always the case for specimen that are small in at least one dimension as for example in the material testing of foils, fibres or micromaterials and certainly also if elevated test–temperatures are preventing standard gauges.

In this paper some widely overlooked sources of errors that — if unavoidable — increase measurement uncertainty beyond the theoretical limit attainable are discussed and the magnitude of their influence is detailed. In particular the following effects are considered: The laser–source wavelength stability as well as its pointing stability, the effects caused by so–called schlieren occurring along the optical path as well as temperature effects causing changes in the systems geometry, thermally influencing the optical parameters of the imaging optics as well as the often overlooked and in most illumination systems unknown radius of curvature of the laser wavefronts used to illuminate the specimen.

Small though as these influences seem, they might contribute significant uncertainties especially in material testing applications where the strain $\varepsilon = \frac{\Delta\ell}{\ell}$ is to be determined out of consecutive measurements of usually small changes in overall length ℓ of the specimens geometry parameter. Typical values of ε are bounded by ± 2000 ppm (the typical range of Hooke’s law for steel). So values of $\Delta\ell$ on the order of tenth of micrometers for typical gauge lengths around 50 mm yield ppm resolutions for ε . Analyzing the above mentioned error sources one can quickly see that all of them, if not taken care of appropriately, carry the potential to cause significantly larger deviations than the resolution sought after demands.

Keywords: laser speckle technique, sources of error, uncertainty

I. Introduction

Some of the non–contacting methods for measuring mechanical strain within specimen or measuring displacements of specimen surface elements (to subsequently determine some mechanical properties of the specimen) rely on the information on surface element positions conveyed by so–called laser–speckles. Speckles only seen when coherent wave phenomena are investigated¹ are caused by waves scattered off of typically rough surfaces interfering in the observers eyes or at the face plate of a camera used. The speckle pattern — a typical one shown in Fig. 1 — appears and actually is random but still bears a deterministic relationship to the scattering surfaces optical properties just as if it were an optical fingerprint of that surface. It

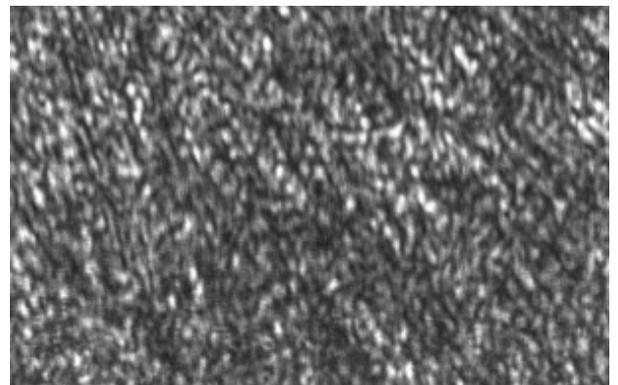


Fig. 1: A typical laser–speckle pattern as scattered off of an optically rough surface.

therefore seems clear that research has been put forward to utilize the information content of speckles in

¹Speckles — most of the time causing deteriorating effects — are experienced in systems utilizing highly coherent laser-light [3], in systems where acoustic wave phenomena are studied like in ultrasonic imaging systems [1] and also in radar systems where the coherent processing of tightly phase–locked but spread in time pulses is necessary to obtain so–called synthetic imaging radar views [2].

various contexts [4, 5, 6, 7]. One particular application that is to be considered in this contribution is the measurement of mechanical strain $\varepsilon = (x_a - x_b)/\ell$ via the determination of the mechanical or thermal stress induced displacements x_a and x_b of two geometrically separated surface elements (A and B) divided by the initial distance ℓ of the surface elements centers as is shown in Fig. 2. Figure 3 shows an actual realization

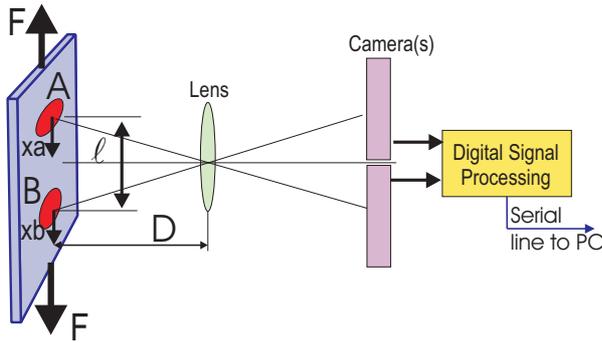


Fig. 2: The optical set-up of a speckle-correlation based strain measurement system. Two lasers illuminate two distinct spots (A and B) on the specimens surface generating speckles that are imaged by the optics (lens) and projected onto the face plate of a single or two (as indicated) CCD-cameras. Stress causes the displacement of the surface underneath the fixed in space laser spots giving rise to equivalent — since caused by the surface roughness — motions of the associated speckles that is recorded by the camera and processed further to give strain.

of such a system that is able to resolve displacement magnitudes down to 100 nm given those error sources discussed below are tightly kept in check. This resolution is independent of the type of pattern matching or pattern tracking algorithm utilized [8] in the digital signal / image processing stage and is — assuming the processing is ideal — as will be shown limited by imponderables of the overall system.

II. Discussion of Error Sources

So far only the working principle of one particular realization of a measurement system has been explained without any reference to the systems pattern tracking algorithm which is of no concern here and assumed to work perfectly. In this section only often overlooked



Fig. 3: An actual optical set-up of a speckle-correlation based strain measurement system.

error contributions are considered that might degrade performance but are usually not even considered by system users who typically blame the manufacturer for not providing a stable enough system.

A. Schlieren

Most people recognize schlieren [9] as the light refracting action due to thermally induced density variations in the atmosphere typically seen close to lit candles, a typical one displayed in Fig. 4, where a gas plume from an unlit cigarette lighter is imaged [10]. The schlieren systems sensitivity set to be able to image the gas plume is around 10 seconds of arc for maximum brightness. A number that might be considered negligible at a first glance for measurement systems. If, however, one is taking the actual imaging geometry of a speckle system into account where typical lengths of the optical path are around 300 mm and temperature gradients over the specimens vertical extension might be a few K or even more the deviation from a straight line propagation of light might be significant.

Following Settles [9] the refractive index of air n_{air} is dependent on its density according to Eqn. 1:

$$n_{air} - 1 = \kappa \cdot \rho \quad (1)$$

with ρ being the mean density ($\rho = 1.29\text{kg/m}^3$) of air, and κ being the Gladstone-Dale coefficient ($\kappa = 2.3 \cdot 10^{-4}\text{m}^3/\text{kg}$). Using the gas state equation (Eqn. 2)

$$\rho = \frac{p}{R_s \cdot T} \quad (2)$$

with p , the atmospheric pressure, T , absolute temperature, and R_s the specific gas constant ($R_s = 287.06$ J/(kg K) for air), the refractive index n_{air} is given by:

$$(n_{air} - 1) = \frac{\kappa \cdot p}{R_s \cdot T}. \quad (3)$$

It can further be shown [9] that optical inhomogenities refract or bend light rays in proportion to their gradients of refractive index in an x,y -plane. The resulting ray curvature is given by:

$$\frac{\partial^2 x}{\partial z^2} = \frac{1}{n_{air}} \cdot \frac{\partial n_{air}}{\partial x}. \quad (4)$$

Integrating once, the component of the angular ray deflection β_x in the x -direction is:

$$\beta_x = \frac{1}{n_{air}} \cdot \int \frac{\partial n_{air}}{\partial x} \partial z \quad (5)$$

For schlieren of extent L along a path on the optical axis this becomes:

$$\beta_x = \frac{L}{n_{air}} \cdot \frac{\partial n_{air}}{\partial x}. \quad (6)$$

Plugging in typical values for gradients and path lengths ($L = 300$ mm, $\ell = 50$ mm, the base length over which the assumed gradient is acting (see Fig. 2), $\Delta T = 1$ K; and $T = 300$ K) results in a refraction angle β_x

$$\beta_x = \frac{0.3}{1.00027 \cdot 0.05} \cdot \frac{2.3 \cdot 10^{-4} \cdot 1.01 \cdot 10^5}{287.06} \cdot \left(\frac{1}{300} - \frac{1}{301} \right)$$

of $5.4 \mu\text{rad}$, which acting upon the assumed path length $L = 300$ mm results in an deviation of Δx_a or Δx_b of around $1.6 \mu\text{m}$; way more than the resolution of the speckle system sought.

B. Pointing Stability of Lasers

An often overlooked factor influencing the systems uncertainty budget can be identified in the lack of pointing stability $\Delta\Theta$ of the laser source(s). A nice treatment on the subject can be found in [11] where also typical short- and longterm stability diagrams of HeNe-lasers are discussed. The typical figures on pointing stability of a well known supplier of semiconductor lasers is to be found in [12]. To mention typical values given in the references $\Delta\Theta \leq 6 \mu\text{rad}/\text{K}$ for a particular series of diode lasers [12] and $\Delta\Theta \leq 1.7 \mu\text{rad}$ over approximately 1000 s for well stabilized HeNe-lasers [11].



Fig. 4: The effect of light passing through an inhomogeneously dense volume of air clearly shows the schlieren effect. Shown here is the density and thus refractive index variation caused by unlit gas escaping from a cigarette lighter (not visible). The image was taken using an experimental schlieren system (from [10]).

If one again considers optical path lengths of 300 mm $1 \mu\text{rad}$ results in a displacement figure for Δx_a or Δx_b of $0.3 \mu\text{m}$, clearly a non-negligible term.

C. Wavefront Distortion of Laser Beam and Geometrical Stability

Yamaguchi has shown in his 1981 paper [6] how to model the speckle pattern movements A_ξ and A_η (see Fig. 5 and Eqns 8) at the location of the camera(s) as functions of various geometrical parameters. These parameters as defined in Eqn. 7 comprise both rigid body translational (a_x, a_y, a_z) as well as rotational parameters ($\Omega_x, \Omega_y, \Omega_z$) of the specimen about all three axes and also incorporating the non-ideal wavefronts of the laser source (by its radius of curvature ℓ_s). In deriving these equations it was assumed that the optical axis of the camera is kept in a plane that is perpendicular to the specimens surface and that the viewed at specimens surface is parallel (to a very high degree) to the straining direction of the loading machine.

$$\begin{aligned}
\Omega &= [\Omega_x, \Omega_y, \Omega_z]^T; \\
a &= [a_x, a_y, a_z]^T; \\
\varepsilon &= \begin{bmatrix} \varepsilon_{xx} & \varepsilon_{xy} \\ \varepsilon_{yx} & \varepsilon_{yy} \end{bmatrix}; \\
\varepsilon_{xx} &= \frac{\partial a_x}{\partial x}; \quad \varepsilon_{yy} = \frac{\partial a_y}{\partial y}; \\
A &= [A_\xi, A_\eta]^T
\end{aligned} \tag{7}$$

The following equations give expressions of speckle shift values in straining direction A_ξ as well as the perpendicular direction A_η as seen by a camera placed ℓ_0 meters away from the specimens surface.

$$\begin{aligned}
A_\xi &= a_x \cdot \left(\frac{\ell_0 \cdot \cos 2\vartheta_s}{\ell_s \cos \vartheta_0} + \cos \vartheta_0 \right) - \\
&\quad - a_z \cdot \left(\frac{\ell_0 \cos \vartheta_s \sin \vartheta_s}{\ell_s \cos \vartheta_0} + \sin \vartheta_0 \right) - \\
&\quad - \varepsilon_{xx} \cdot \ell_0 \cdot \left(\frac{\sin \vartheta_s}{\cos \vartheta_0} + \tan \vartheta_0 \right) + \\
&\quad + \Omega_y \cdot \ell_0 \cdot \left(\frac{\cos \vartheta_s}{\cos \vartheta_0} + 1 \right) \\
A_\eta &= a_y \cdot \left(\frac{\ell_0}{\ell_s} + 1 \right) - \\
&\quad - \varepsilon_{xy} \cdot (\sin \vartheta_s + \sin \vartheta_0) - \\
&\quad - \Omega_x \cdot \ell_0 (\cos \vartheta_s + \cos \vartheta_0) - \\
&\quad - \Omega_z \cdot \ell_0 \cdot (\sin \vartheta_s + \sin \vartheta_0)
\end{aligned} \tag{8}$$

From these equations one can derive the magnitude of possible strain / displacement measurement errors due to misalignment, rotations and bending of the specimen during loading as well as those caused by non-collimated laser sources.

Again, as with the uncertainty contributions above a numerical example consistent with above assumptions shall be given here. Let's assume a radius of curvature $\ell_s = 1500$ mm (this is a realistic assumption since for diode lasers for example the laser light can safely be assumed to emanate from a point source at the laser diodes location. The collimating optics attached to the laser doesn't change that fact much since the collimation needs to be set such as to average over the astigmatism of the beam), the projection distance $\ell_0 = 150$ mm, all angles being normal angles and a rigid body motion of the specimen in straining direction

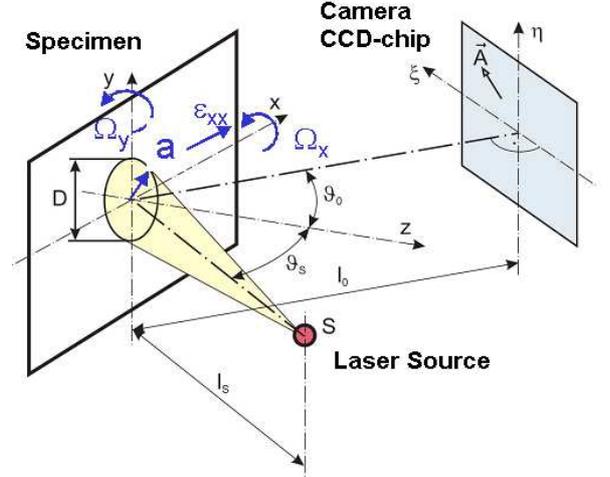


Fig. 5: Definition of the geometry to derive laser speckle displacements A_ξ, A_η as seen by the camera(s).

$a_x = 100\mu\text{m}$ (this assumption results from assuming a base length ℓ as seen in Fig. 2 of 50 mm and utilizing elastic strain values ($\varepsilon_{\max} = 2 \cdot 10^{-3}$)). Then an error contribution for $\Delta A_\eta = a_x \cdot \ell_0 / \ell_s = 10\mu\text{m}$ for a true value of $100\mu\text{m}$, a 10% error.

D. Thermal Effects

As might be inferred from Fig. 3 a typical system is built on an aluminum base with opto-mechanical components also made of black-anodized aluminum. This material as compared to stainless steel for example exhibits a rather large linear coefficient of thermal expansion $\alpha_{alu} = 23 \cdot 10^{-6}/\text{K}$. Again assuming sensible numbers on the heating up of the system during an experiment (2K per 10 min for example), and given a base plate to optical axis distance of 50 mm an apparent movement of the specimen (as seen through a gradually thermally expanding optics) results in an error contribution Δx_a or Δx_b of $23 \cdot 10^{-6} \cdot 0.05 \cdot 2 = 2.3\mu\text{m}$. Again an order of magnitude more than the resolution sought.

E. An Example and Conclusions

In this contribution some easily overlooked sources of errors in laser-speckle systems (as well as many other optical systems) were discussed and it was shown that each and every error term can in the adverse case be

orders of magnitude larger than the typical resolution a user assumes from these systems. To give the reader a feeling how well corrected systems (the one shown in Fig. 3) might perform a short-term stability test is shown in Fig. 6. The laser source was a diode laser (warm-up time > 2 hours), the environmental conditions were that of a laboratory, five measurements per second were taken over a few minutes. Please note that the resolution as defined by the signal processing algorithm was deliberately set to $0.1\mu\text{m}$ which is way below the short-term stability experienced.

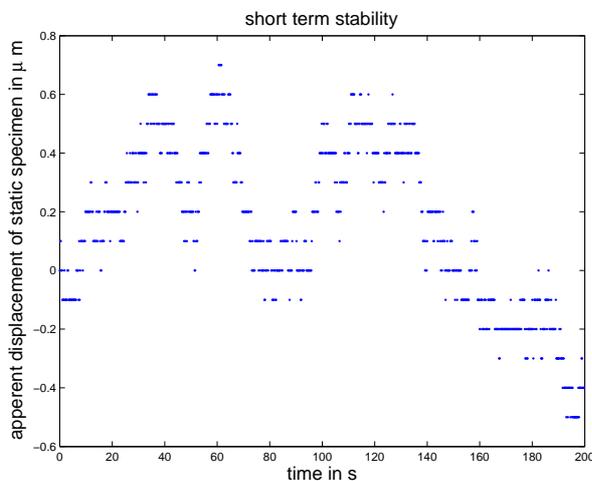


Fig. 6: A typical drift as seen in a laser-speckle system. The specimen was a copper slab mounted to a loading machine with no force applied. The measurement system was tightly locked to the base of the loading machine so as to circumvent differential motion and experiencing vibrations.

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